



SLOVENSKI STANDARD

SIST EN 61189-1:2001

01-marec-2001

Test methods for electrical materials, printed boards and other interconnection structures and assemblies - Part 1: General test methods and methodology

Test methods for electrical materials, printed boards and other interconnection structures and assemblies - Part 1: General test methods and methodology

Prüfverfahren für Elektromaterialien, Leiterplatten und andere Verbindungsstrukturen und Baugruppen - Teil 1: Allgemeine Prüfverfahren und -methodik

Méthodes d'essais pour les matériaux électriques, les cartes imprimées et autres structures d'interconnexion et ensembles - Partie 1: Méthodes d'essai générales et méthodologie

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Ta slovenski standard je istoveten z: EN 61189-1:1997

ICS:

31.180	Tiskana vezja (TIV) in tiskane plošče	Printed circuits and boards
31.190	Sestavljeni elektronski elementi	Electronic component assemblies

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en

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EUROPEAN STANDARD
NORME EUROPÉENNE
EUROPÄISCHE NORM

EN 61189-1

April 1997

ICS 31.180

Descriptors: Printed boards, interconnection structures, electrical materials, assemblies, general test methods, methodology

English version

**Test methods for electrical materials,
interconnection structures and assemblies
Part 1: General test methods and methodology
(IEC 61189-1:1997)**

Méthodes d'essais pour les matériaux
électriques, les structures
d'interconnexion et les ensembles
Partie 1: Méthodes d'essai générales
et méthodologie
(CEI 61189-1:1997)

Prüfverfahren für Elektromaterialien,
Verbindungsstrukturen und Baugruppen
Teil 1: Allgemeine Prüfverfahren und
Methodik
(IEC 61189-1:1997)

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This European Standard was approved by CENELEC on 1997-03-11. CENELEC members are bound to comply with the CEN/CENELEC Internal Regulations which stipulate the conditions for giving this European Standard the status of a national standard without any alteration.

Up-to-date lists and bibliographical references concerning such national standards may be obtained on application to the Central Secretariat or to any CENELEC member.

This European Standard exists in three official versions (English, French, German). A version in any other language made by translation under the responsibility of a CENELEC member into its own language and notified to the Central Secretariat has the same status as the official versions.

CENELEC members are the national electrotechnical committees of Austria, Belgium, Denmark, Finland, France, Germany, Greece, Iceland, Ireland, Italy, Luxembourg, Netherlands, Norway, Portugal, Spain, Sweden, Switzerland and United Kingdom.

CENELEC

European Committee for Electrotechnical Standardization
Comité Européen de Normalisation Electrotechnique
Europäisches Komitee für Elektrotechnische Normung

Central Secretariat: rue de Stassart 35, B - 1050 Brussels

Foreword

The text of document 52/635/FDIS, future edition 1 of IEC 61189-1, prepared by IEC TC 52, Printed circuits, in cooperation with IEC TC 91, Surface mounting technology, and IEC TC 50, Environmental testing, was submitted to the IEC-CENELEC parallel vote and was approved by CENELEC as EN 61189-1 on 1997-03-11.

The following dates were fixed:

- latest date by which the EN has to be implemented
at national level by publication of an identical
national standard or by endorsement (dop) 1997-12-01
- latest date by which the national standards conflicting
with the EN have to be withdrawn (dow) 1997-12-01

This part 1 of EN 61189 is to be used in conjunction with the other parts of EN 61189 and with the EN 60068 series.

Annexes designated "normative" are part of the body of the standard.
Annexes designated "informative" are given for information only.
In this standard, annex ZA is normative and annexes A and B are informative.
Annex ZA has been added by CENELEC.

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The text of the International Standard IEC 61189-1:1997 was approved by CENELEC as a European Standard without any modification.

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Annex ZA (normative)**Normative references to international publications
with their corresponding European publications**

This European Standard incorporates by dated or undated reference, provisions from other publications. These normative references are cited at the appropriate places in the text and the publications are listed hereafter. For dated references, subsequent amendments to or revisions of any of these publications apply to this European Standard only when incorporated in it by amendment or revision. For undated references the latest edition of the publication referred to applies (including amendments).

NOTE: When an international publication has been modified by common modifications, indicated by (mod), the relevant EN/HD applies.

<u>Publication</u>	<u>Year</u>	<u>Title</u>	<u>EN/HD</u>	<u>Year</u>
IEC 60068-1	1988	Environmental testing Part 1: General and guidance	EN 60068-1 ¹⁾	1994

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1) EN 60068-1 includes the corrigendum October 1988 and A1:1992 to IEC 60068-1.

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**NORME
INTERNATIONALE
INTERNATIONAL
STANDARD**

**CEI
IEC**

61189-1

Première édition
First edition
1997-03

**Méthodes d'essai pour les matériaux
électriques, les structures d'interconnexion
et les ensembles –**

**Partie 1:
Méthodes d'essai générales et méthodologie**

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**Test methods for electrical materials,
interconnection structures and assemblies –**

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Part 1: 6944adc96e6f/sist-en-61189-1-2001

General test methods and methodology

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International Electrotechnical Commission
Telefax: +41 22 919 0300

3, rue de Varembé Geneva, Switzerland
e-mail: inmail@iec.ch IEC web site <http://www.iec.ch>



Commission Electrotechnique Internationale
International Electrotechnical Commission
Международная Электротехническая Комиссия

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INTERNATIONAL ELECTROTECHNICAL COMMISSION

TEST METHODS FOR ELECTRICAL MATERIALS,
INTERCONNECTION STRUCTURES AND ASSEMBLIES –

Part 1: General test methods and methodology

FOREWORD

- 1) The IEC (International Electrotechnical Commission) is a worldwide organization for standardization comprising all national electrotechnical committees (IEC National Committees). The object of the IEC is to promote international co-operation on all questions concerning standardization in the electrical and electronic fields. To this end and in addition to other activities, the IEC publishes International Standards. Their preparation is entrusted to technical committees; any IEC National Committee interested in the subject dealt with may participate in this preparatory work. International, governmental and non-governmental organizations liaising with the IEC also participate in this preparation. The IEC collaborates closely with the International Organization for Standardization (ISO) in accordance with conditions determined by agreement between the two organizations.
- 2) The formal decisions or agreements of the IEC on technical matters express, as nearly as possible, an international consensus of opinion on the relevant subjects since each technical committee has representation from all interested National Committees.
- 3) The documents produced have the form of recommendations for international use and are published in the form of standards, technical reports or guides and they are accepted by the National Committees in that sense.
- 4) In order to promote international unification, IEC National Committees undertake to apply IEC International Standards transparently to the maximum extent possible in their national and regional standards. Any divergence between the IEC Standard and the corresponding national or regional standard shall be clearly indicated in the latter.
- 5) The IEC provides no marking procedure to indicate its approval and cannot be rendered responsible for any equipment declared to be in conformity with one of its standards.
- 6) Attention is drawn to the possibility that some of the elements of this International Standard may be the subject of patent rights. The IEC shall not be held responsible for identifying any or all such patent rights.

International Standard IEC 61189-1 has been prepared by IEC technical committee 52: Printed circuits, in cooperation with technical committee 91: Surface mounting technology, and technical committee 50: Environmental testing.

The text of this standard is based on the following documents:

FDIS	Report on voting
52/635/FDIS	52/699/RVD

Full information on the voting for the approval of this standard can be found in the report on voting indicated in the above table.

Annexes A and B are for information only.

This standard should be used in conjunction with the following parts of IEC 61189, under generic title *Test methods for electrical materials, interconnection structures and assemblies*:

Part 2: Test methods for materials for interconnection structures

Part 3: Test methods for interconnection structures (printed boards)

Part 4: Test methods for electronic components assembling characteristics

Part 5: Test methods printed board assemblies,

and also the following standard:

IEC 60068: *Environmental testing*

INTRODUCTION

IEC 61189 relates to test methods for printed boards and printed board assemblies, as well as related materials or component robustness, irrespective of their method of manufacture.

The standard is divided into separate parts, covering information for the designer and the test methodology engineer or technician. Each part has a specific focus; methods are grouped according to their application and numbered sequentially as they are developed and released.

In some instances test methods developed by other TCs (e.g. TC 50) have been reproduced from existing IEC standards in order to provide the reader with a comprehensive set of test methods. When this situation occurs, it will be noted on the specific test method; if the test method is reproduced with minor revision, those paragraphs that are different are identified.

This part of IEC 61189 contains test methods for evaluating printed boards and other forms of interconnection structures. The methods are self-contained, with sufficient detail and description so as to achieve uniformity and reproducibility in the procedures and test methodologies.

The tests shown in this standard are grouped according to the following principles:

P: preparation/conditioning methods

V: visual test methods

D: dimensional test methods

C: chemical test methods

M: mechanical test methods

E: electrical test methods

N: environmental test methods

X: miscellaneous test methods

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To facilitate reference to the tests, to retain consistency of presentation, and to provide for future expansion, each test is identified by a number (assigned sequentially) added to the prefix (group code) letter showing the group to which the test method belongs.

The test method numbers have no significance with respect to an eventual test sequence; that responsibility rests with the relevant specification that calls for the method being performed. The relevant specification, in most instances, also describes pass/fail criterion.

The letter and number combinations are for reference purposes, to be used by the relevant specification. Thus "3D02" represents the second dimensional test method described in this publication IEC 61189-3.

In short, in this example, 3 is the part of IEC standard (61189-3), D is the group of methods, and 02 is the test number.

A list of all test methods included in this standard, as well as those under consideration is given in annex B. This annex will be reissued whenever new tests are introduced.

TEST METHODS FOR ELECTRICAL MATERIALS, INTERCONNECTION STRUCTURES AND ASSEMBLIES –

Part 1: General test methods and methodology

1 Scope and object

This part of IEC 61189 is a catalogue of test methods representing methodologies and procedures that can be applied to test materials used for manufacturing interconnection structures (printed boards) and assemblies.

2 Normative reference

The following normative document contains provisions which, through reference in this text, constitute provisions of this part of IEC 61189. At the time of publication, the edition indicated was valid. All normative documents are subject to revision, and parties to agreements based on this part of IEC 61189 are encouraged to investigate the possibility of applying the most recent edition of the normative document indicated below. Members of IEC and ISO maintain registers of currently valid International Standards.

IEC 60068-1: 1988, *Environmental testing – Part 1: General and guidance*

3 Accuracy, precision and resolution

Errors and uncertainties are inherent in all measurement processes. The information given below enables valid estimates of the amount of error and uncertainty to be taken into account.

Test data serve a number of purposes which include:

- to monitor a process;
- to enhance confidence in quality conformance;
- to arbitrate between customer and supplier.

In any of these circumstances, it is essential that confidence can be placed upon the test data in terms of:

- accuracy: calibration of the test instruments and/or system;
- precision: the repeatability and uncertainty of the measurement;
- resolution: the suitability of the test instrument and/or system.

3.1 Accuracy

The regime by which routine calibration of the test equipment is undertaken shall be clearly stated in the quality documentation of the supplier or agency conducting the test, and shall meet the requirements in ISO 9002, clause 4.11.

The calibration shall be conducted by an agency having accreditation to a national or international measurement standard institute. There should be an uninterrupted chain of calibration to a national or international standard.